



TPD1E10B06-Q1 采用 0402 封装、电容为 12pF 且击穿电压为 6V 的单通道 ESD 保护二极管

1 特性

- 符合 AEC-Q101
- IEC 61000-4-2 4 级静电放电 (ESD) 保护
 - ±30kV 接触放电
 - ±30kV 气隙放电
- ISO 10605 (330pF, 330Ω) ESD 保护
 - ±8kV 接触放电
 - ±15kV 气隙放电
- IEC 61000-4-5 浪涌保护
 - 6A (8μs/20μs)
- I/O 电容 12pF (典型值)
- R_{DYN}: 0.38Ω (典型值)
- 直流击穿电压: ±6V (最小值)
- 超低泄漏电流: 100nA (最大值)
- 钳位电压: 10V (I_{PP} = 1A 时的典型值)
- 工业温度范围: -40°C 至 +125°C
- 节省空间的 0402 封装

2 应用

- 终端设备:
 - 音响主机
 - 高级音频设备
 - 外部放大器
 - 车身控制模块
 - 网关
 - 远程信息处理
 - 摄像机模块
- 接口:
 - 音频线路
 - 按钮
 - 存储器接口
 - 通用输入/输出 (GPIO)

3 说明

TPD1E10B06-Q1 是一款双向 TVS ESD 保护二极管, 采用符合行业标准的小型 0402 封装。这种封装便于节省空间的应用 (R_{DYN} 较低且 IEC 额定值较高) 放置组件。TPD1E10B06-Q1 的额定 ESD 冲击耗散值高于 IEC 61000-4-2 4 级国际标准规定的最高水平, 原因是其 ESD 电压可轻松升至 5000V, 超出足以损坏众多集成电路的电压值, 但在极端条件下, 这些电压将显著升高。例如, 在湿度较低的环境下, 电压可超过 20000V。

低动态电阻 (0.38Ω) 和低钳位电压 (1A I_{PP} 时为 10V) 确保提供系统级瞬变保护, 针对设计经受的 ESD 事件充分提供保护。该器件还具有一个 12pF IO 电容, 非常适用于音频线路、按钮、存储器接口和 GPIO。

该器件具有一款非汽车类应用型号: [TPD1E10B06](#)。

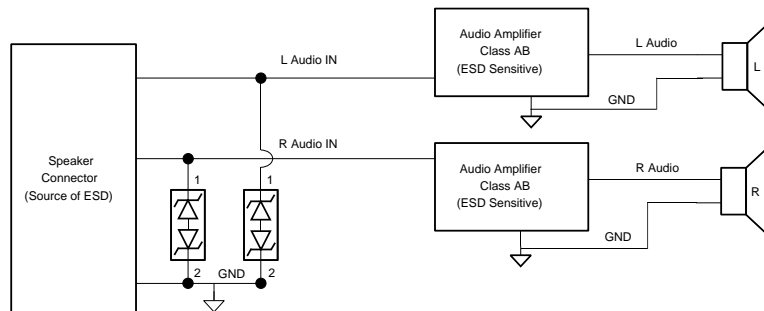
器件信息⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
TPD1E10B06-Q1	X1SON (2)	0.60mm x 1.00mm
TPD1E10B06 ⁽²⁾	X1SON (2)	0.60mm x 1.00mm

(1) 要了解所有可用封装, 请参见数据表末尾的可订购产品附录。

(2) 该器件不属于 TPD1E10B06-Q1 数据表, 请参见 [TPD1E10B06](#) 了解所有电气参数和器件特性

典型应用电路原理图



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4 修订历史记录

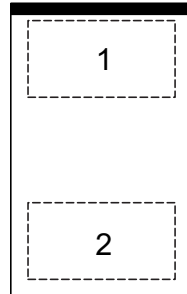
Changes from Original (August 2016) to Revision A

Page

• 已更改 器件状态“产品预览”至“量产数据”	1
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5 Pin Configuration and Functions

**DPY Package
2-Pin X1SON
Top View**



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	IO	I/O	ESD Protected I/O. Connect other pin to ground
2	IO		

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
I_{PP}	Peak pulse current ($t_p = 8/20 \mu s$)		6	A
P_{PP}	Peak pulse power ($t_p = 8/20 \mu s$)		90	W
T_A	Operating temperature	–40	125	°C
T_{stg}	Storage temperature	–65	155	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD—AEC Specification Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	V
		Charged-device model (CDM), per AEC Q100-011	
		±2500	
		±1000	

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 ESD Ratings—IEC Specification

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	IEC 61000-4-2 contact discharge	V
		IEC 61000-4-2 air-gap discharge	
		±30000	
		±30000	

6.4 ESD Ratings—ISO Specification

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	ISO 10605 (330 pF, 330 Ω) contact discharge	V
		ISO 10605 (330 pF, 330 Ω) air-gap discharge	
		±8000	
		±15000	

6.5 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
T_A	Operating free-air temperature	–40	125	°C
Pin 1 to 2 or Pin 2 to 1	Operating voltage	–5.5	5.5	V

6.6 Thermal Information

THERMAL METRIC ⁽¹⁾		TPD1E10B06-Q1	UNIT
		DPY (X1SON)	
		2 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	615.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	404.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	493.3	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	127.7	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	493.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	162	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.7 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	Pin 1 to 2 or Pin 2 to 1			5.5	V
I_{LEAK}	Leakage current	Pin 1 = 5 V, Pin 2 = 0 V			100	nA
$V_{Clamp1,2}$	Clamp voltage with ESD strike on pin 1, pin 2 grounded	$I_{PP} = 1\text{ A}$, $t_p = 8\text{ to }20\text{ }\mu\text{s}^{(1)}$		10		V
		$I_{PP} = 5\text{ A}$, $t_p = 8\text{ to }20\text{ }\mu\text{s}^{(1)}$		14		
$V_{Clamp2,1}$	Clamp voltage with ESD strike on pin 2, pin 1 grounded	$I_{PP} = 1\text{ A}$, $t_p = 8\text{ to }20\text{ }\mu\text{s}^{(1)}$		8.5		V
		$I_{PP} = 5\text{ A}$, $t_p = 8\text{ to }20\text{ }\mu\text{s}^{(1)}$		14		
R_{DYN}	Dynamic resistance	Pin 1 to Pin 2 ⁽²⁾		0.32		Ω
		Pin 2 to Pin 1 ⁽²⁾		0.38		
C_{IO}	I/O capacitance	$V_{IO} = 2.5\text{ V}$; $f = 1\text{ MHz}$		12		pF
$V_{BR1,2}$	Break-down voltage, pin 1 to pin 2	$I_{IO} = 1\text{ mA}$	6			V
$V_{BR2,1}$	Break-down voltage, pin 2 to pin 1	$I_{IO} = 1\text{ mA}$	6			V

(1) Nonrepetitive current pulse 8 to 20 μs exponentially decaying waveform according to IEC 61000-4-5

(2) Extraction of $R_{DYNAMIC}$ using least squares fit of TLP characteristics between $I_{PP} = 10\text{ A}$ and $I_{PP} = 20\text{ A}$.

6.8 Typical Characteristics

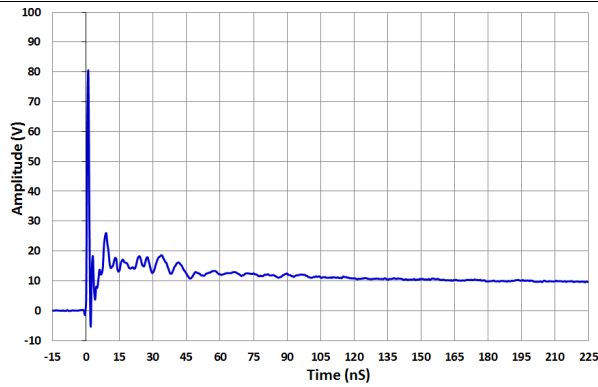


Figure 1. IEC 61000-4-2 Clamp Voltage +8-kV Contact ESD

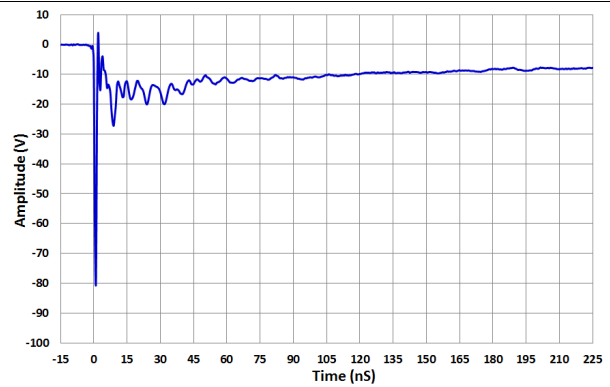


Figure 2. IEC 61000-4-2 Clamp Voltage -8-kV Contact ESD

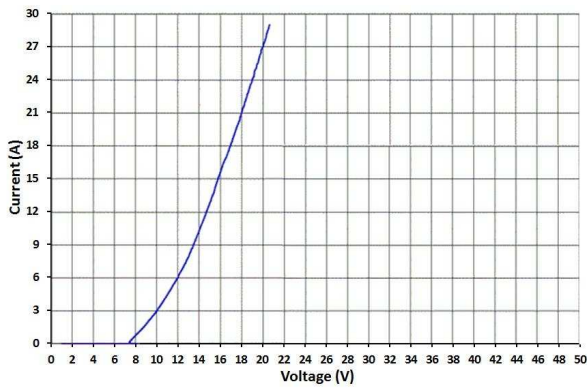


Figure 3. Transmission Line Pulse (TLP) Waveform Pin 1 to Pin 2

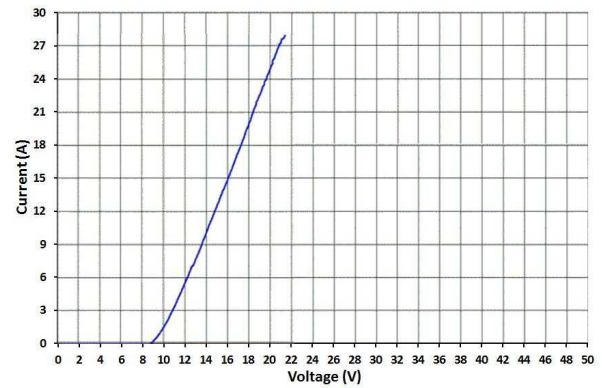


Figure 4. Transmission Line Pulse (TLP) Waveform Pin 2 to Pin 1

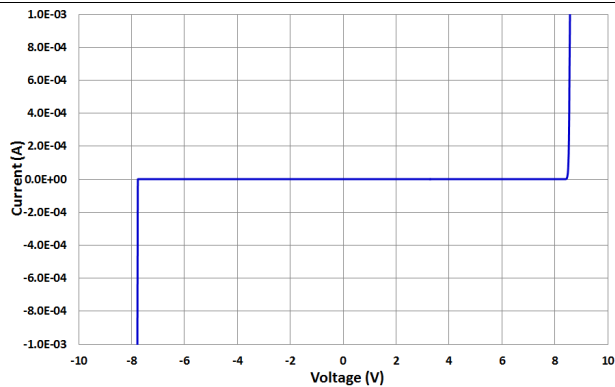


Figure 5. IV Curve

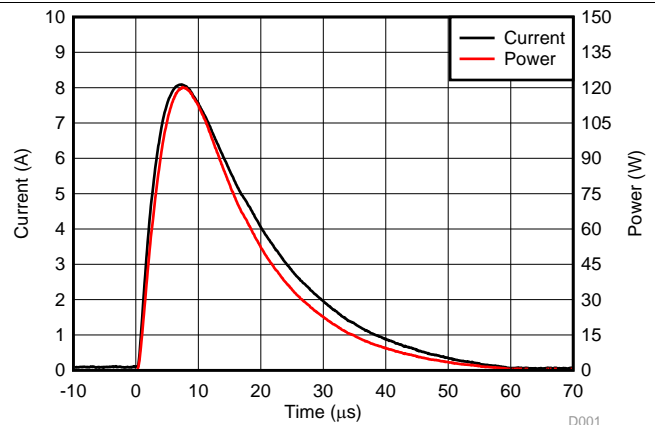
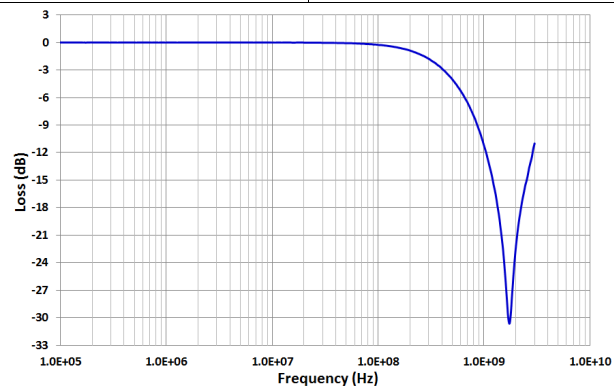
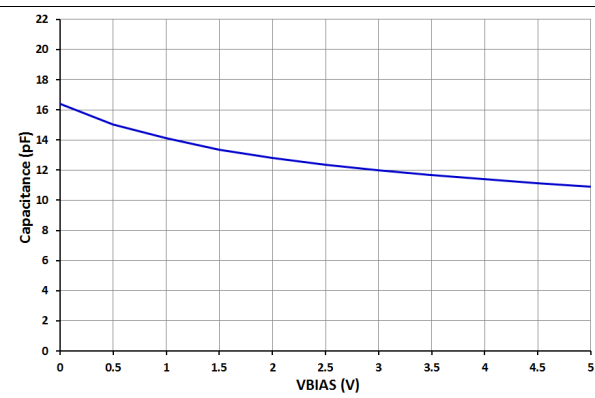
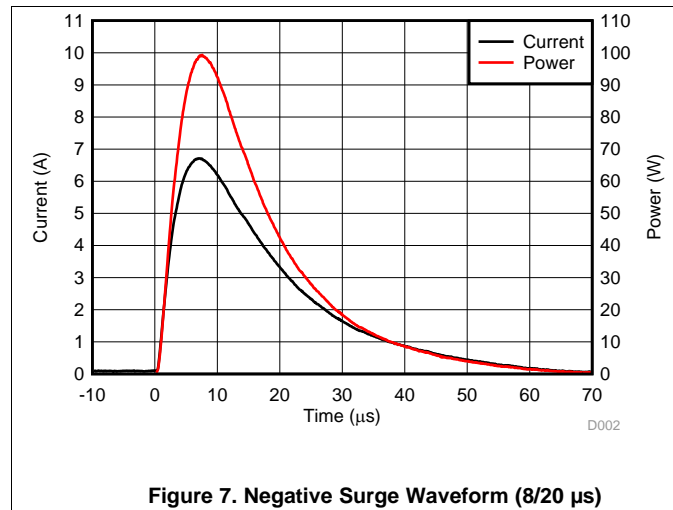


Figure 6. Positive Surge Waveform (8/20 μ s)

Typical Characteristics (continued)



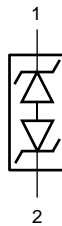
7 Detailed Description

7.1 Overview

The TPD1E10B06-Q1 is a single-channel ESD TVS diode in a small 0402 package. This TVS protection product offers ± 30 -kV IEC air-gap, ± 30 -kV contact ESD protection, and has an ESD clamp circuit with a back-to-back TVS diode for bipolar or bidirectional signal support. The 12-pF line capacitance of this ESD protection diode is suitable for a wide range of applications supporting data rates up to 400 Mbps. The 0402 package is an industry standard and is convenient for component placement in space-saving applications.

Typical application of this ESD protection product is the circuit protection for audio lines, push buttons, memory interfaces, and general-purpose I/O ports. This ESD clamp is a good fit for the protection of the end equipments such as head units, premium audio, external amplifiers, and many other automotive applications.

7.2 Functional Block Diagram



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7.3 Feature Description

The TPD1E10B06-Q1 is a bidirectional TVS with high ESD protection level. This device protects circuit from ESD strikes up to ± 30 -kV contact and ± 30 -kV air-gap specified in the IEC 61000-4-2 level 4 international standard. The device can also handle up to 6-A surge current (IEC 61000-4-5 8/20 μ s). The I/O capacitance of 12 pF supports a data rate up to 400 Mbps. This clamping device has a small dynamic resistance, which makes the clamping voltage low when the device is actively protecting other circuits. For example, the clamping voltage is only 10 V when the device is taking 1-A transient current. The breakdown is bidirectional so that this protection device is a good fit for GPIO and especially audio lines which carry bidirectional signals. Low leakage allows the diode to conserve power when working below the V_{RWM} . The industrial temperature range of -40°C to $+125^{\circ}\text{C}$ makes this ESD device work at extensive temperatures in most environments. The space-saving 0402 package can fit into many flexible spaces.

7.3.1 AEC-Q101 Qualified

This device is qualified to AEC-Q101 standards and is qualified to operate from -40°C to $+125^{\circ}\text{C}$.

7.3.2 IEC 61000-4-2 ESD Protection

The I/O pins can withstand ESD events up to ± 30 -kV contact and ± 30 -kV air according to the IEC 61000-4-2 standard. An ESD-surge clamp diverts the current to ground.

7.3.3 ISO 10605 ESD Protection

The I/O pins can withstand ESD events at least ± 8 -kV contact and ± 15 -kV air according to the ISO 10605 (330 pF, 330 Ω) standard. An ESD-surge clamp diverts the current to ground.

7.3.4 IEC 61000-4-5 Surge Protection

The IO pins can withstand surge events up to 6 A (8/20 μ s waveform). An ESD-surge clamp diverts this current to ground.

7.3.5 IO Capacitance

The capacitance between the I/O pins 12 pF. This capacitance support data rates up to 400 Mbps.

Feature Description (continued)

7.3.6 Dynamic Resistance

The IO pins feature an ESD clamp that has a low R_{DYN} of 0.32 Ω (Pin 1 to Pin 2) and 0.38 Ω (Pin 2 to Pin 1) which prevents system damage during ESD events.

7.3.7 DC Breakdown Voltage

The DC breakdown voltage between the IO pins is a minimum of 6 V. This ensures that sensitive equipment is protected from surges above the reverse standoff voltage of 5.5 V.

7.3.8 Ultra Low Leakage Current

The IO pins feature an ultra-low leakage current of 100 nA (maximum) with a bias of 5 V.

7.3.9 Clamping Voltage

The IO pins feature an ESD clamp that is capable of clamping the voltage to 10 V ($I_{PP} = 1$ A) and 14V ($I_{PP} = 5$ A).

7.3.10 Industrial Temperature Range

This device features an industrial operating range of -40°C to $+125^{\circ}\text{C}$

7.3.11 Space-Saving Footprint

This device features a space-saving, industry standard 0402 footprint.

7.4 Device Functional Modes

The TPD1E10B06-Q1 is a passive clamp that has low leakage during normal operation when the voltage between pin 1 and pin 2 is below V_{RWM} and activates when the voltage between pin 1 and pin 2 goes above V_{BR} . During IEC ESD events, transient voltages as high as ± 30 kV can be clamped between the two pins. When the voltages on the protected lines fall below the trigger voltage, the device reverts back to the low leakage passive state.

8 Application and Implementation

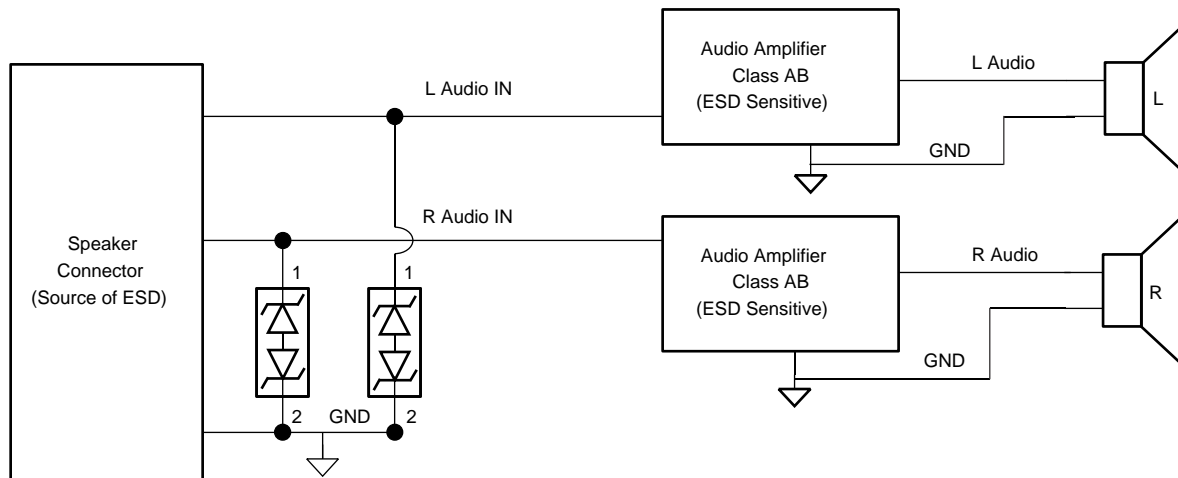
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

When a system contains a human interface connector, the system becomes vulnerable to large system-level ESD strikes that standard ICs cannot survive. TVS ESD protection diodes are typically used to suppress ESD at these connectors. The TPD1E10B06-Q1 is a single-channel ESD protection device containing back-to-back TVS diodes, which is typically used to provide a path to ground for dissipating ESD events on bidirectional signal lines between a human interface connector and a system. As the current from ESD passes through the device, only a small voltage drop is present across the diode structure. This is the voltage presented to the protected IC. The low R_{DYN} of the triggered TVS holds this voltage, V_{CLAMP} , to a tolerable level to the protected IC.

8.2 Typical Application



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Figure 10. Typical Application Schematic

8.2.1 Design Requirements

For this design example, the two TPD1E10B06-Q1s are used to protect left and right audio channels. For this audio application, the system parameters shown in [Table 1](#) are known.

Table 1. Design Parameters

DESIGN PARAMETER	VALUE
Audio amplifier class	AB
Audio signal voltage range	–3 V to 3 V
Audio frequency content	20 Hz to 20 kHz
Required IEC 61000-4-2 ESD protection	±20-kV contact, ±25-kV air-gap

8.2.2 Detailed Design Procedure

To begin the design process, some parameters must be decided upon; the designer must make sure:

- Voltage range on the protected line must not exceed the reverse standoff voltage of the TVS diode(s) (V_{RWM})
- Operating frequency is supported by the I/O capacitance C_{IO} of the TVS diode

- IEC 61000-4-2 protection requirement is covered by the IEC performance of the TVS diode

For this application, the audio signal voltage range is -3 V to 3 V . The V_{RWM} for the TVS is -5.5 V to 5.5 V ; therefore, the bidirectional TVS does not break down during normal operation, and therefore normal operation of the audio signal is not effected because of the signal voltage range. In this application, a bidirectional TVS like TPD1E10B06-Q1 is required.

Next, consider the frequency content of this audio signal. In this application with the class AB amplifier, the frequency content is from 20 Hz to 20 kHz ; ensure that the TVS I/O capacitance does not distort this signal by filtering it. With the TPD1E10B06-Q1 typical capacitance of 12 pF , which leads to a typical 3-dB bandwidth of 400 MHz , this diode has sufficient bandwidth to pass the audio signal without distorting it.

Finally, the human interface in this application requires above standard Level 4 IEC 61000-4-2 system-level ESD protection ($\pm 20\text{-kV}$ Contact, $\pm 25\text{-kV}$ Air-Gap). A standard TVS cannot survive this level of IEC ESD stress. However, the TPD1E10B06-Q1 can survive at least $\pm 30\text{-kV}$ Contact/ $\pm 30\text{-kV}$ Air-Gap. Therefore, the device can provide sufficient ESD protection for the interface, even though the requirements are stringent. For any TVS diode to provide the full range of ESD protection capabilities, as well as to minimize the noise and EMI disturbances the board will see during ESD events, a system designer must use proper board layout of their TVS ESD protection diodes. See the [Layout](#) section for instructions on properly laying out TPD1E10B06-Q1.

8.2.3 Application Curves

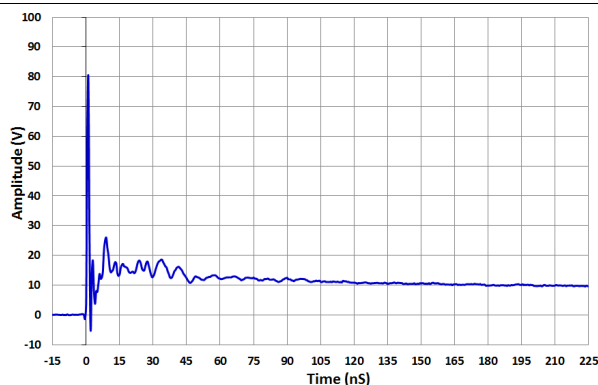


Figure 11. IEC 61000-4-2 Clamp Voltage +8-kV Contact ESD

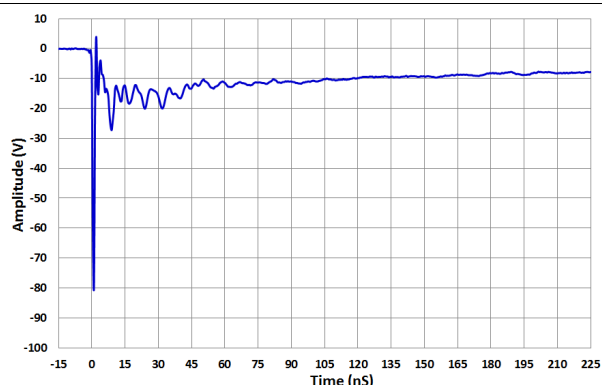


Figure 12. IEC 61000-4-2 Clamp Voltage -8-kV Contact ESD

9 Power Supply Recommendations

This device is a passive TVS diode-based ESD protection device, therefore there is no requirement to power it. Take care to make sure that the maximum voltage specifications for each pin are not violated.

10 Layout

10.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
 - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
 - The PCB designer must minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
 - Electric fields tend to build up on corners, increasing EMI coupling.
- If pin 1 or pin 2 is connected to ground, use a thick and short trace for this return path.

10.2 Layout Example

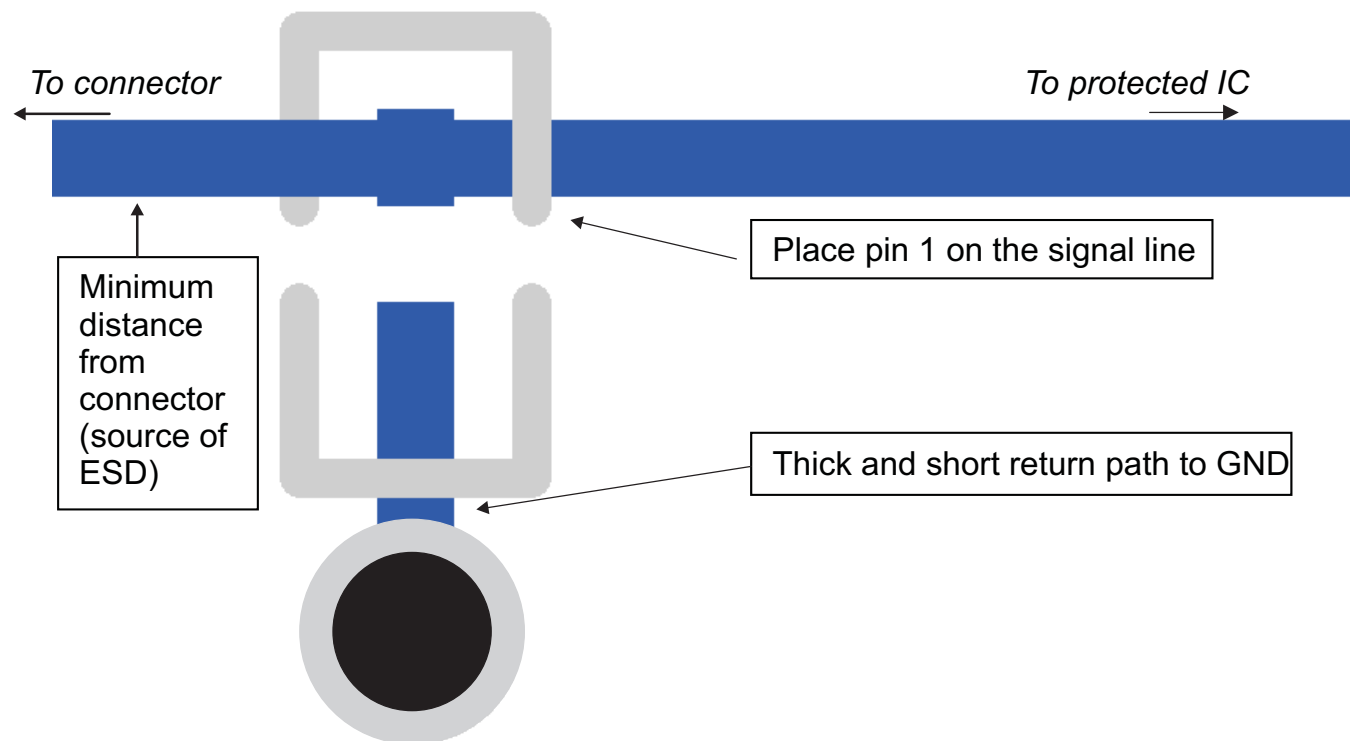


Figure 13. Layout Recommendation

11 器件和文档支持

11.1 文档支持

11.1.1 相关文档

相关文档如下：

- 《TPD1E10B06-Q1 评估模块用户指南》
- 阅读和理解 ESD 保护数据表
- 《ESD 布局指南》
- 《ESD 保护二极管 EVM》

11.2 接收文档更新通知

如需接收文档更新通知，请访问 ti.com 上的器件产品文件夹。点击右上角的提醒我 (Alert me) 注册后，即可每周定期收到已更改的产品信息。有关更改的详细信息，请查阅已修订文档中包含的修订历史记录。

11.3 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.4 商标

E2E is a trademark of Texas Instruments.

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11.5 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPD1E10B06QDPYRQ1	ACTIVE	X1SON	DPY	2	10000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD1E10B06QDPYRQ1	X1SON	DPY	2	10000	180.0	9.5	0.73	1.13	0.5	2.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS

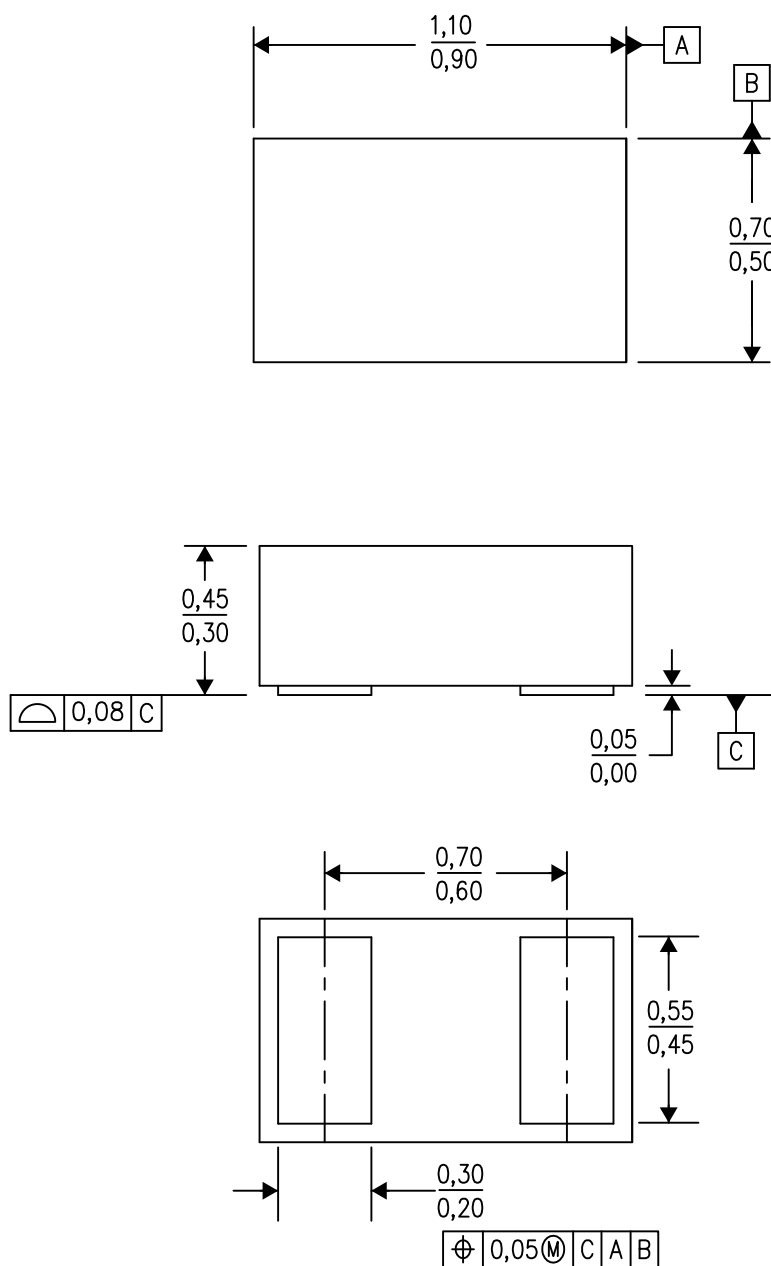


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPD1E10B06QDPYRQ1	X1SON	DPY	2	10000	189.0	185.0	36.0

DPY (R-PX1SON-N2)

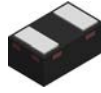
PLASTIC SMALL OUTLINE NO-LEAD



4211012/D 08/14

- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5-1994.
B. This drawing is subject to change without notice.
C. SON (Small Outline No-Lead) package configuration.

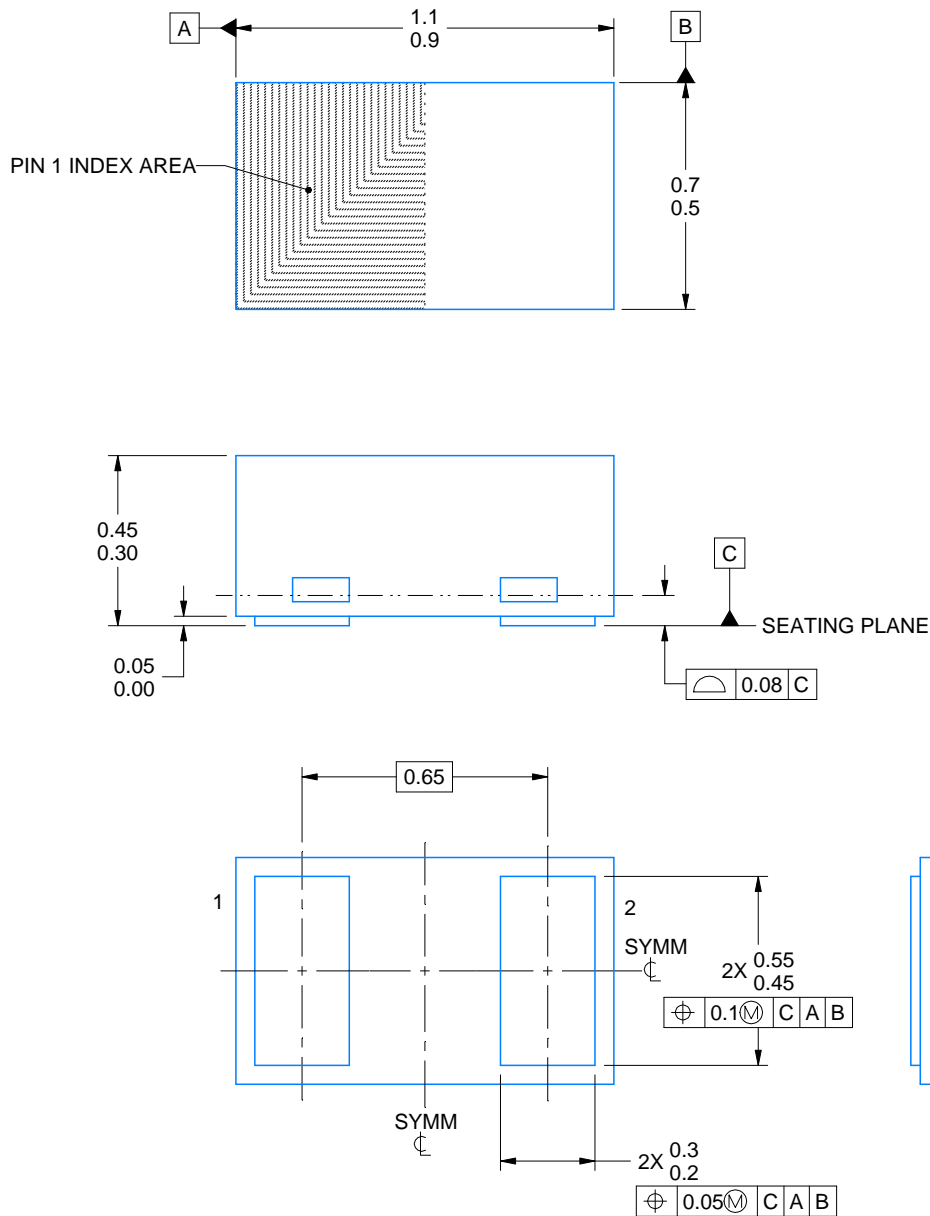
DPY0002A



PACKAGE OUTLINE

X1SON - 0.45 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4224561/B 03/2021

NOTES:

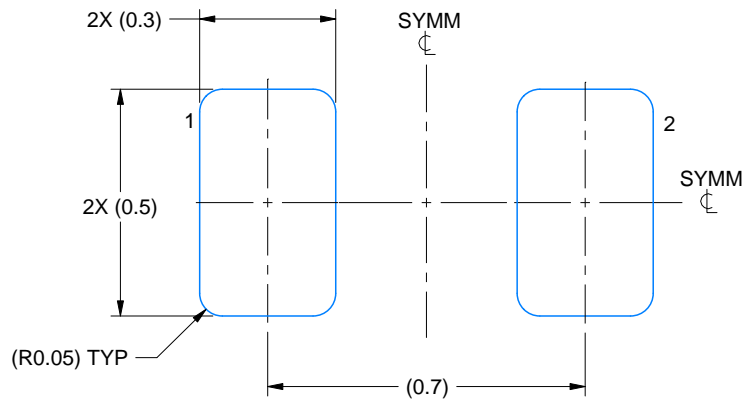
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M
2. This drawing is subject to change without notice.

EXAMPLE BOARD LAYOUT

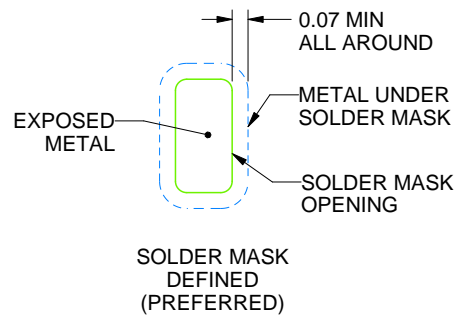
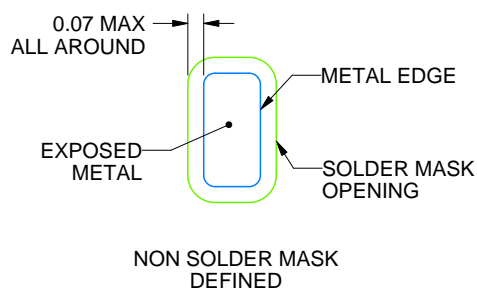
DPY0002A

X1SON - 0.45 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:60X



SOLDER MASK DETAILS

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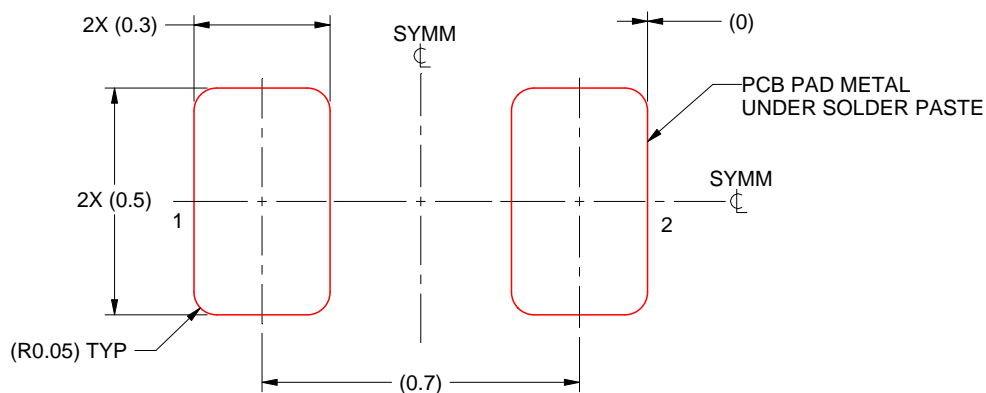
NOTES: (continued)

- For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

DPY0002A

X1SON - 0.45 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE:60X

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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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